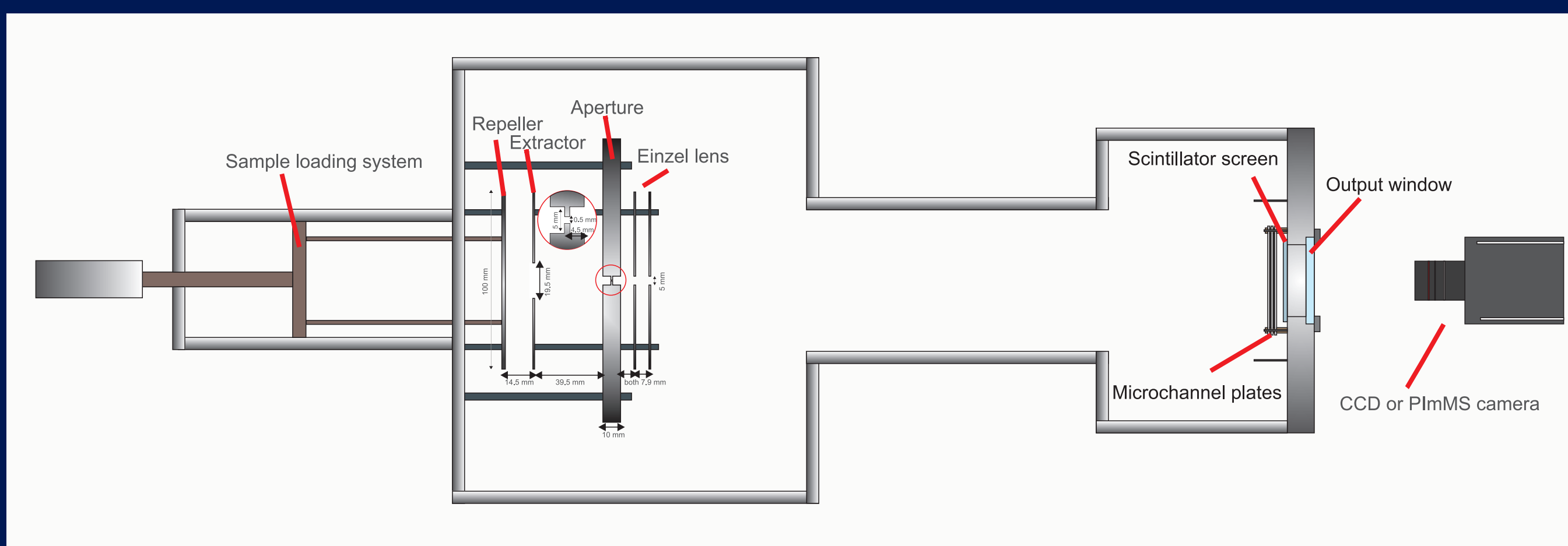


## Aims

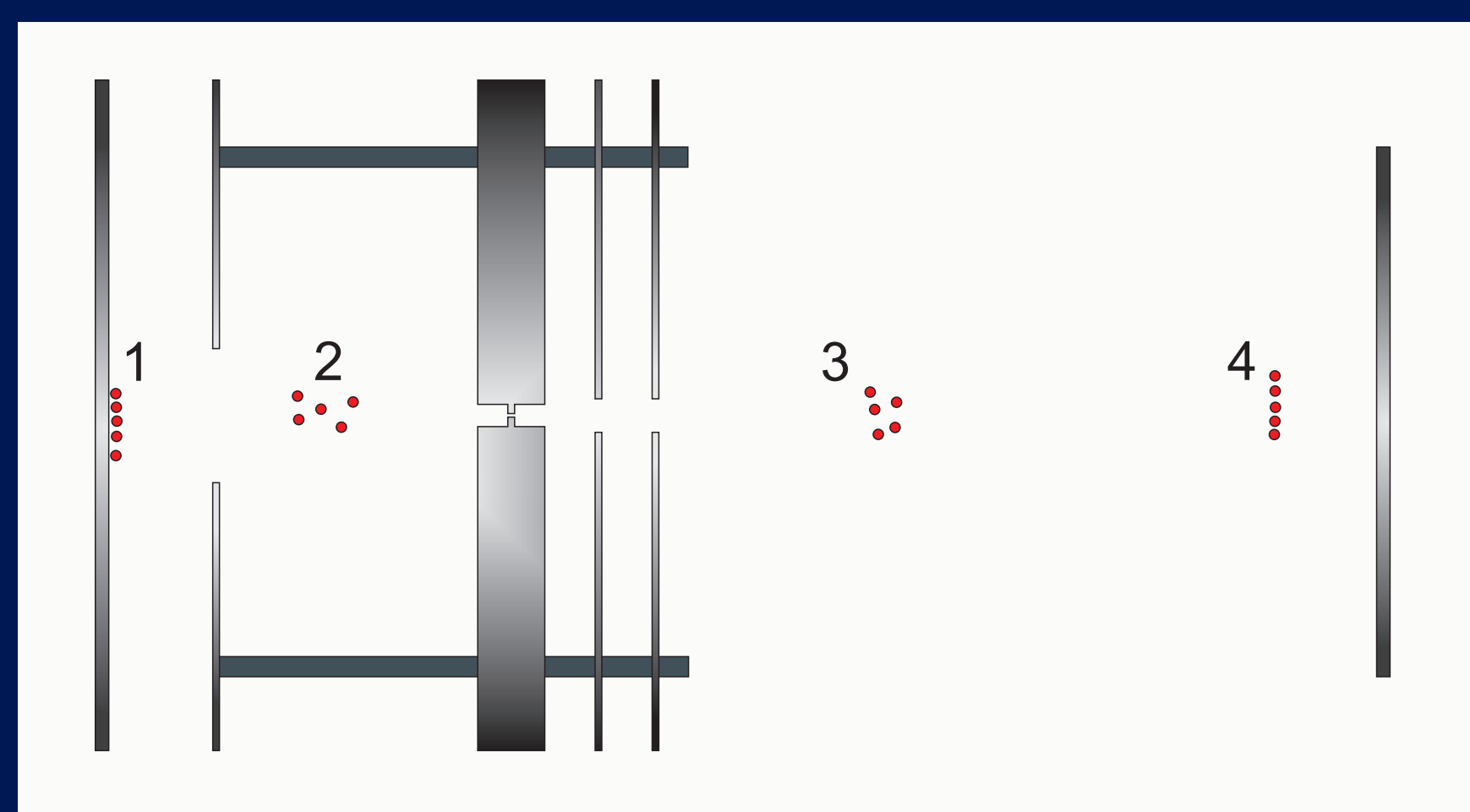
- To construct a linear microscope imaging mass spectrometer
- To apply a post extraction different extraction (PEDA) method to gain an enhanced ToF resolution [1,2]
- To develop a new scintillator based imaging ToF detector

## Experimental setup



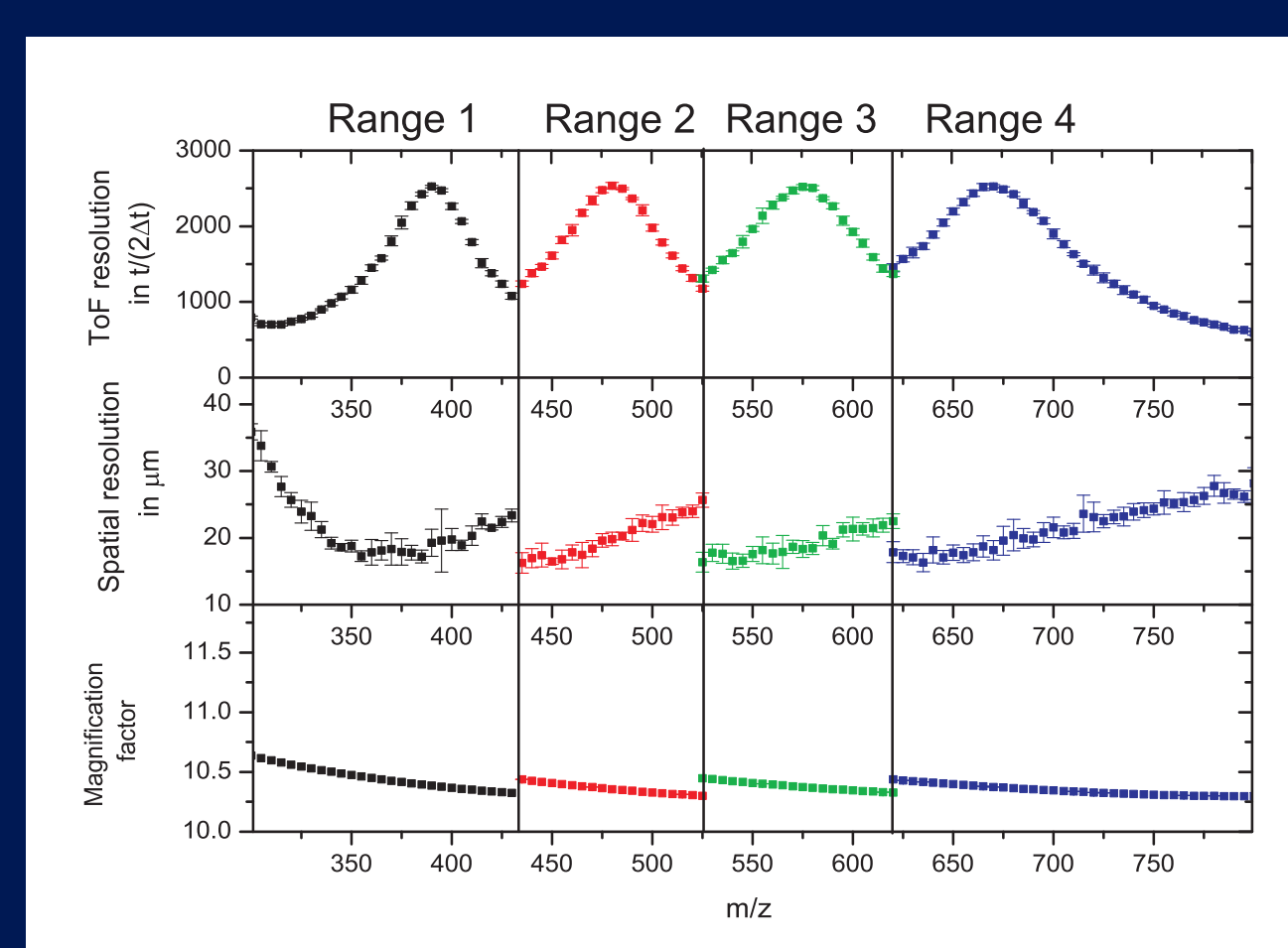
- 4 mm experimental field of view
- MALDI/LDI ionisation of a large sample section
- Spatial mapping onto a novel scintillator based imaging detector
- Image collection using a CCD or a multi mass imaging PImMS camera [3]

## Ion extraction using the PEDA technique

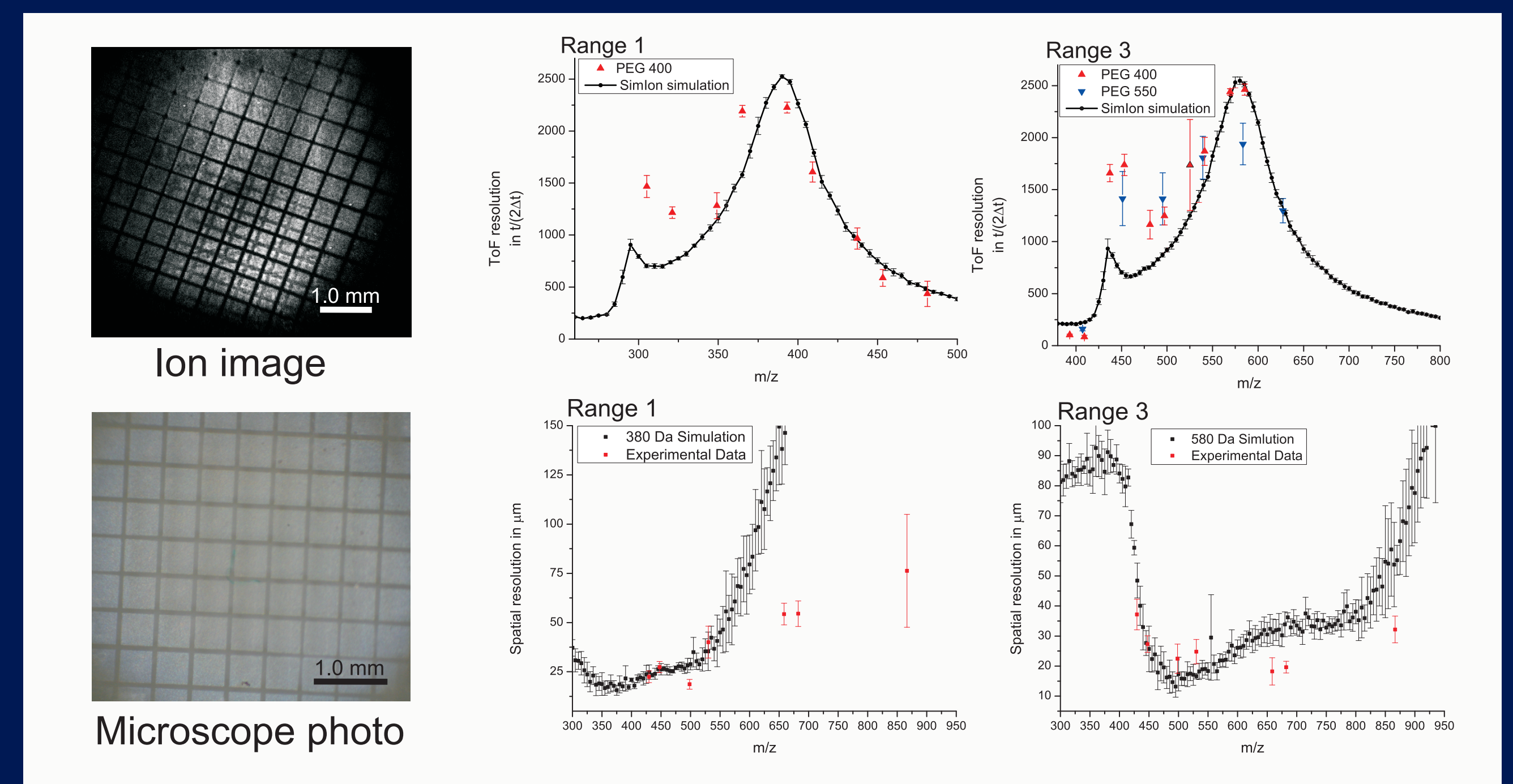


- Ions are extracted immediately after ionisation using a static electric field formed between the repeller and the extractor electrode.
- Once the ions of interest are situated between the extractor electrode and the Einzel lens, the extractor is pulsed to a higher acceleration potential.
- The ions are time/spatially focussed as they traverse the field free region
- When the time focus plane is coincident with the detector plane, microscope mode imaging with high ToF resolution becomes possible. The initial ion velocity spread can be corrected.

- ToF and spatial resolution, are a result of the mass dependent focussing properties of the ion optics
- For two different particle masses, it is possible to maintain the mapping position by adjusting the applied potentials, but maintaining the voltage ratios between the electrodes
- Multiple mass ranges can be defined in which the spectrometer specifications are maintained.
- Spectrometer can be tuned to any mass range



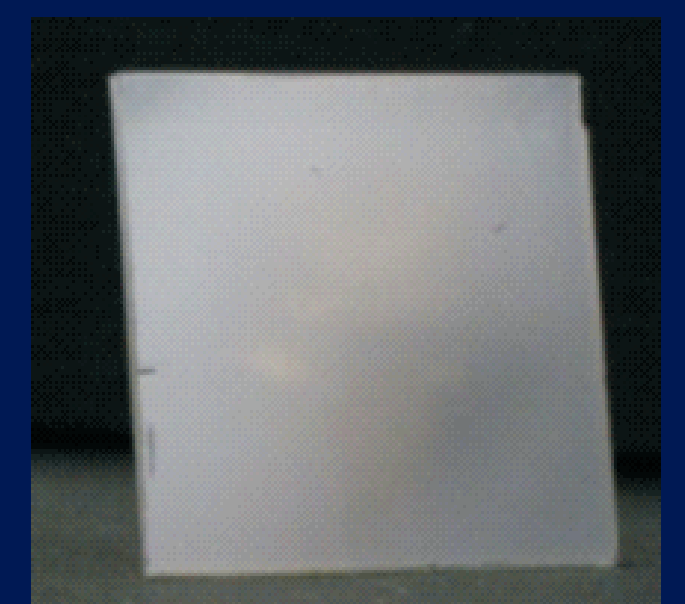
## Experimental results



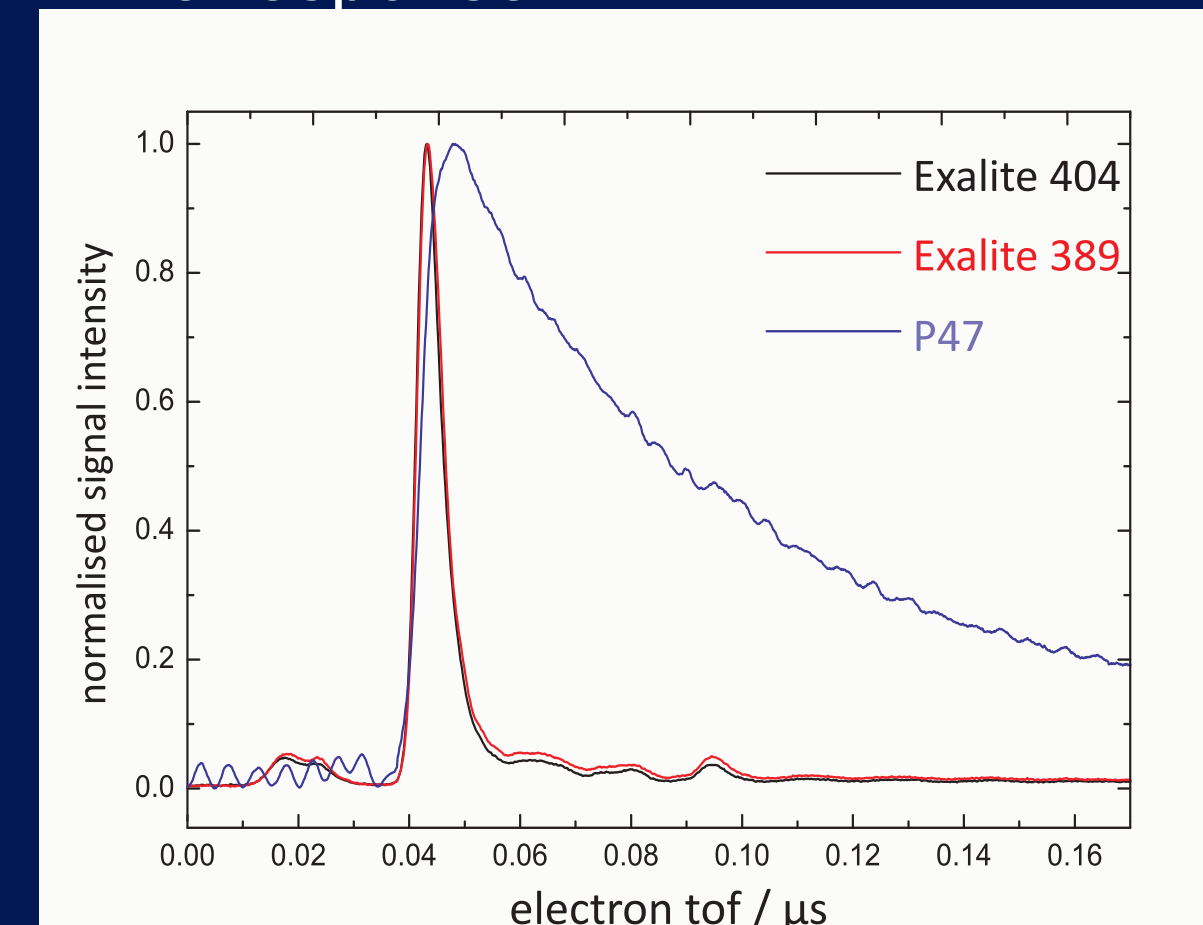
- Microscope mode imaging mass spectrometry was performed with 20 μm spatial resolution
- Experimental field of view of 4 mm
- Time of flight resolutions of  $t/2\Delta t = 2000$
- Optimum spectrometer specification could be tuned to any mass of interest

## Development of a fast scintillation detector

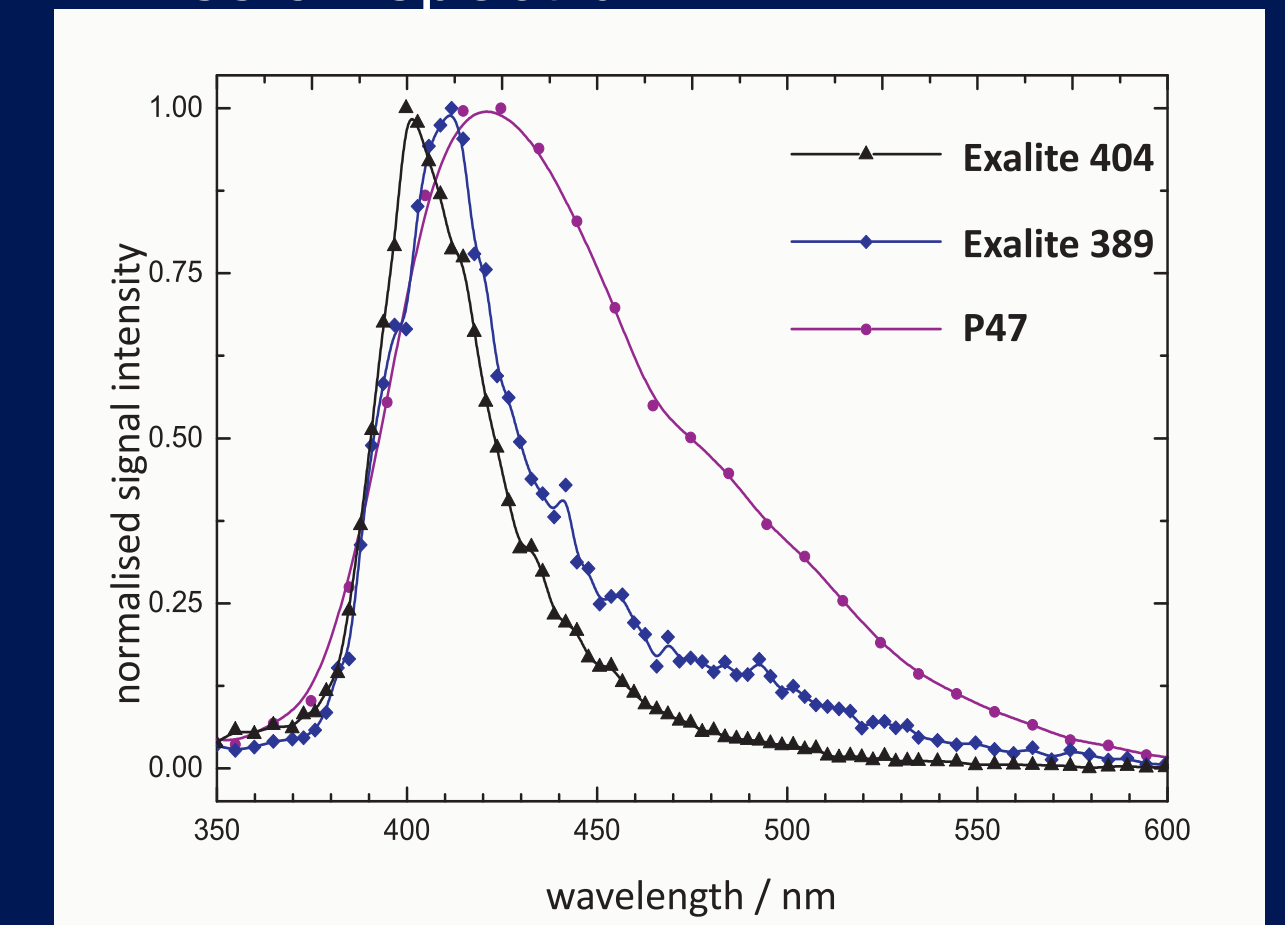
- Imaging mass spectrometry experiments require fast MCP phosphor screen detectors to access a high ToF resolution
- Conventional systems are limited by the fluorescence decay time of P47 phosphor screens (70 ns)
- Here, we present a new, dye based scintillator screen, which allows particle detection with high timing precision
- An enhanced brightness and sensitivity could be determined for the new dye screens in comparison to a P47 phosphor
- The screen was designed to be combined with the PImMS camera, which allows multi-mass imaging with a time precision of sub 12.5 ns.



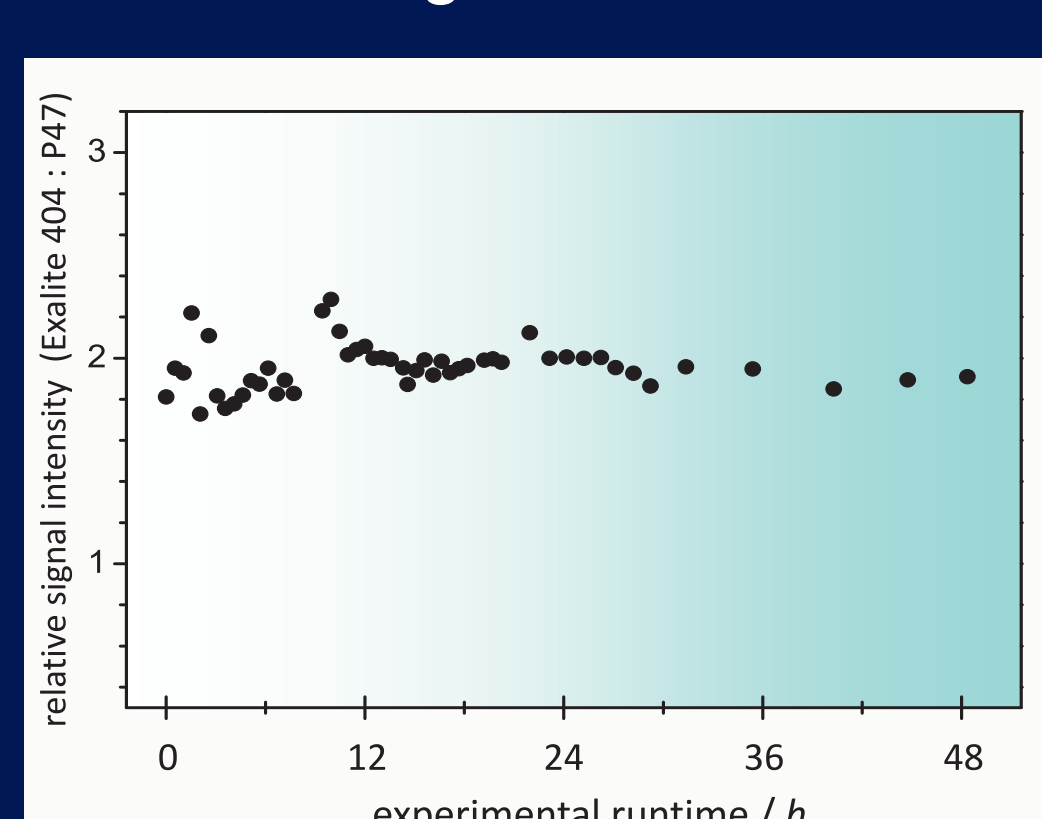
### Time response



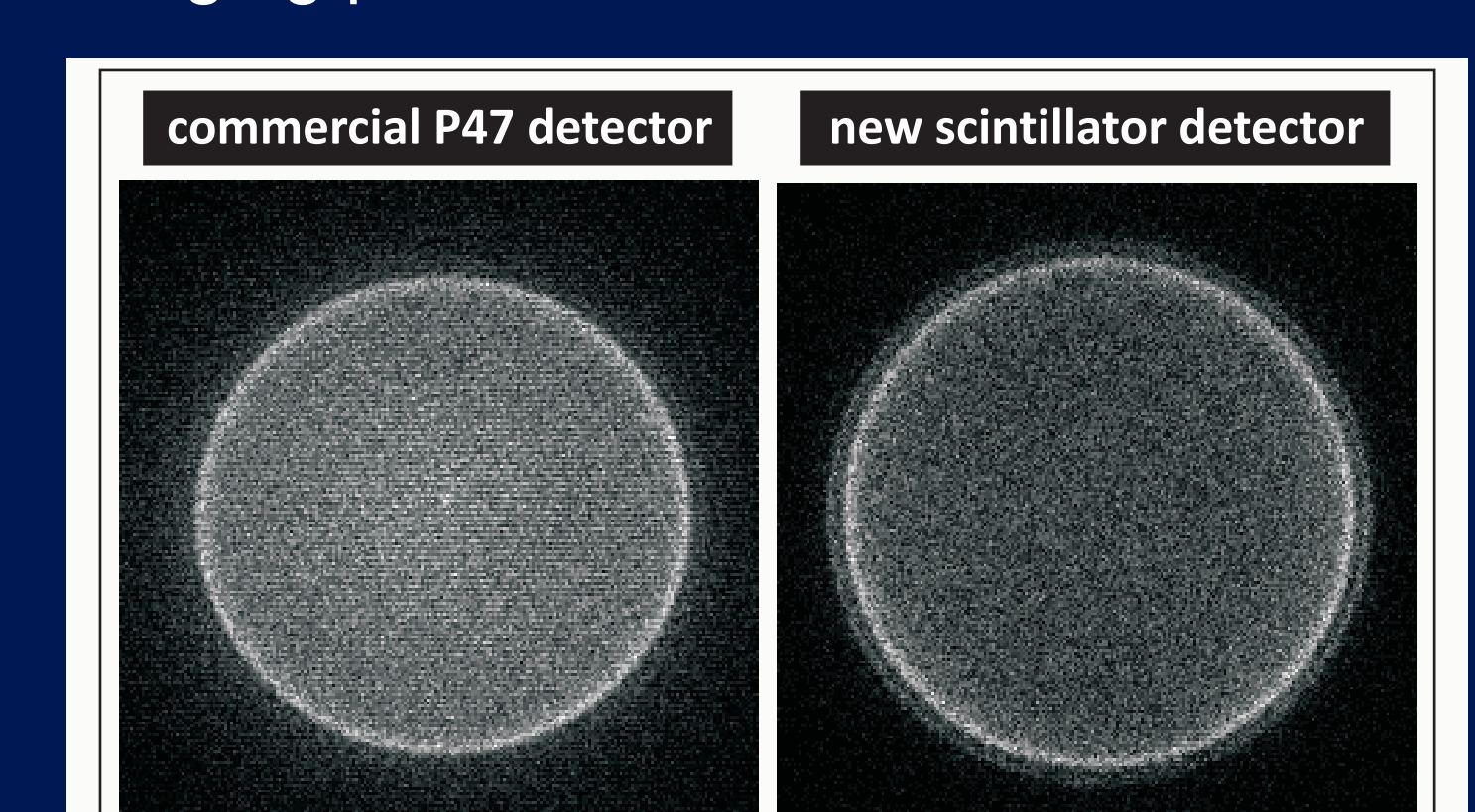
### Emission spectrum



### Relative brightness and stability



### Imaging performance



Scintillator	Type	Emission $\lambda_{max}$ (nm)	Relative emission efficiency	Decay constant
P43 (YAG)	Inorganic	545	483-725	> 1 ms
<b>P47</b>	Inorganic	<b>430</b>	<b>145-156</b>	<b>70 ns</b>
Anthracene	Organic Crystal	447	100	30 ns
BC-404	Plastic	423	65	2.4 ns

Scintillator	Type	Emission $\lambda_{max}$ (nm)	Relative emission efficiency	Decay constant
Exalite 389	Organic Dye	404	50-70	< 3 ns
<b>Exalite 404</b>	Organic Dye	<b>412</b>	<b>200-300</b>	<b>&lt; 3 ns</b>
BBOT	Organic Dye	480	~70*	< 3 ns
LYSO	Inorganic Crystal	430	~80*	49 ns

\*for direct ion detection only (see Section 5)